

Search Notes

Application/Control No.

10/757,829

Examiner

Tai Van Nguyen

Applicant(s)/Patent under
Reexamination

SHIRAISHI ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	25.35 852, 846	7/27/2005	TN
	594		
310	334, 336	7/27/2005	TN
	162		
73	810, 861		
	601, 801		
501	80		
516	33		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Dexter Tubang Primary class; 29	7/27/2005	TN
Consulted with Thomas Dougherty Primary class; 310	7/27/2005	TN
Review parent Application Sn# 10/434,516 and references cited therein	7/27/2005	TN
East search	12/10/2007	TN